

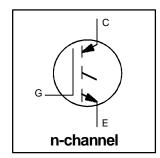
IRGBC40M-S

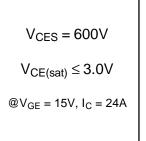
INSULATED GATE BIPOLAR TRANSISTOR

Short Circuit Rated Fast IGBT

Features

- Short circuit rated 10µs @ 125°C, V GE = 15V
- Switching-loss rating includes all "tail" losses
- Optimized for medium operating frequency (1 to 10kHz)

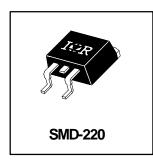




Description

Insulated Gate Bipolar Transistors (IGBTs) from International Rectifier have higher usable current densities than comparable bipolar transistors, while at the same time having simpler gate-drive requirements of the familiar power MOSFET. They provide substantial benefits to a host of high-voltage, high-current applications.

These new short circuit rated devices are especially suited for motor control and other applications requiring short circuit withstand capability.



Absolute Maximum Ratings

	Parameter	Max.	Units
V _{CES}	Collector-to-Emitter Voltage	600	V
I _C @ T _C = 25°C	Continuous Collector Current	40	
I _C @ T _C = 100°C	Continuous Collector Current	24	Α
I _{CM}	Pulsed Collector Current ①	80	
I_{LM}	Clamped Inductive Load Current ②	80	
t _{sc}	Short Circuit Withstand Time	10	μs
V_{GE}	Gate-to-Emitter Voltage	±20	V
E _{ARV}	Reverse Voltage Avalanche Energy 3	15	mJ
P _D @ T _C = 25°C	Maximum Power Dissipation	160	W
P _D @ T _C = 100°C	Maximum Power Dissipation	65	
TJ	Operating Junction and	-55 to +150	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 sec.	300 (0.063 in. (1.6mm) from case)	
	Mounting torque, 6-32 or M3 screw.	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	_	_	0.77	
$R_{\theta JA}$	Junction-to-Ambient, (PCB mount)**	_	_	40	°C/W
$R_{\theta JA}$	Junction-to-Ambient, typical socket mount	_	_	80	
Wt	Weight	_	2 (0.07)	_	g (oz)

^{**} When mounted on 1" square PCB (FR-4 or G-10 Material)

For recommended footprint and soldering techniques refer to application note #AN-994.

Electrical Characteristics @ T _ J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions	
$V_{(BR)CES}$	Collector-to-Emitter Breakdown Voltage	600		_	V	$V_{GE} = 0V, I_{C} = 250\mu A$	
V _{(BR)ECS}	Emitter-to-Collector Breakdown Voltage @	20		_	V	$V_{GE} = 0V, I_{C} = 1.0A$	
$\Delta V_{(BR)CES}/\Delta T_J$	Temp. Coeff. of Breakdown Voltage	_	0.70	_	V/°C	$V_{GE} = 0V, I_{C} = 1.0mA$	
V _{CE(on)}	Collector-to-Emitter Saturation Voltage	_	2.0	3.0		$I_C = 24A$ $V_{GE} = 15V$	
		_	2.6	_	V	I _C = 40A	
		_	2.4	_		I _C = 24A, T _J = 150°C	
V _{GE(th)}	Gate Threshold Voltage	3.0		5.5		$V_{CE} = V_{GE}$, $I_C = 250\mu A$	
$\Delta V_{GE(th)}/\Delta T_J$	Temperature Coeff. of Threshold Voltage	_	-12	_	mV/°C	$V_{CE} = V_{GE}$, $I_C = 250\mu A$	
g fe	Forward Transconductance §	9.2	12	_	S	$V_{CE} = 100V, I_{C} = 24A$	
I _{CES}	Zero Gate Voltage Collector Current	_		250	μΑ	$V_{GE} = 0V, V_{CE} = 600V$	
		_	_	1000		V _{GE} = 0V, V _{CE} = 600V, T _J = 150°C	
I _{GES}	Gate-to-Emitter Leakage Current	_	_	±100	nA	V _{GE} = ±20V	

Switching Characteristics @ T $_J$ = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge (turn-on)	-	59	80		I _C = 24A
Q_{ge}	Gate - Emitter Charge (turn-on)	1	8.6	10	nC	$V_{CC} = 400V$
Q_{gc}	Gate - Collector Charge (turn-on)	ı	25	42		$V_{GE} = 15V$
t _{d(on)}	Turn-On Delay Time	1	26			$T_J = 25^{\circ}C$
t _r	Rise Time	ı	37	_	ns	$I_C = 24A$, $V_{CC} = 480V$
t _{d(off)}	Turn-Off Delay Time	1	240	410		$V_{GE} = 15V$, $R_G = 10\Omega$
t _f	Fall Time	-	230	420		Energy losses include "tail"
Eon	Turn-On Switching Loss	-	0.75	_		
E _{off}	Turn-Off Switching Loss	1	1.65		mJ	
E _{ts}	Total Switching Loss	-	2.4	3.6		
t _{sc}	Short Circuit Withstand Time	10			μs	$V_{CC} = 360V, T_J = 125^{\circ}C$
						V_{GE} = 15V, R_G = 10 Ω , V_{CPK} < 500V
t _{d(on)}	Turn-On Delay Time		28	_		$T_{J} = 150^{\circ}C,$
t _r	Rise Time	1	37		ns	$I_C = 24A$, $V_{CC} = 480V$
t _{d(off)}	Turn-Off Delay Time	ı	380	_		$V_{GE} = 15V$, $R_G = 10\Omega$
t _f	Fall Time	1	460			Energy losses include "tail"
E _{ts}	Total Switching Loss	1	4.5		mJ	
LE	Internal Emitter Inductance	_	7.5	_	nΗ	Measured 5mm from package
C _{ies}	Input Capacitance	_	1500			$V_{GE} = 0V$
Coes	Output Capacitance		190	_	pF	$V_{CC} = 30V$
C _{res}	Reverse Transfer Capacitance	_	20		Ţ	f = 1.0MHz

Notes:

- 1 Repetitive rating; V $_{\mbox{\scriptsize GE}}\mbox{=}20\mbox{\scriptsize V},$ pulse width limited by max. junction temperature.
- ③ Repetitive rating; pulse width limited by maximum junction temperature.
- S Pulse width 5.0µs, single shot.

- @ $V_{CC}\!\!=\!\!80\%(V_{CES}),~V_{GE}\!\!=\!\!20V,~L\!\!=\!\!10\mu H,$ $R_{G}\!\!=\!10\Omega$
- 4 Pulse width \leq 80 μ s; duty factor \leq 0.1%.

Refer to Section D for the following:

Package Outline 2 - SMD-220 Section D - page D-12